

ICICT 2022 February 21(Mon) – 24(Thu)
London, United Kingdom

Zoom : Virtual Room D

Feb. 24, 2022 GMT
10:46am - 11:00am

Current-Driven IGBT Gate Driver Circuit Considering Four Operation Regions

Souma Yamamoto, Yudai Abe, Akio Iwabuchi,
Jun-ichi Matsuda, Anna Kuwana,
Haoyang Du, Takafumi Kamio, Takashi Hosono,
Shogo Katayama, Haruo Kobayashi

Gunma University

Sanken Electric Co. Ltd

OUTLINE

- **Research Background and Objective**
- **IGBT Evaluation Circuit**
- **IGBT Current Drive Simulation**
 - **Current Gate Driver Circuit**
 - **Simulation Results**
- **Gate Current Automatic Control**
 - **Analog Value**
 - **Digital Value**
- **Conclusion and Challenges**

OUTLINE

- **Research Background and Objective**
- **IGBT Evaluation Circuit**
- **IGBT Current Drive Simulation**
 - **Current Gate Driver Circuit**
 - **Simulation Results**
- **Gate Current Automatic Control**
 - **Analog Value**
 - **Digital Value**
- **Conclusion and Challenges**

Research Background

IGBTs have advantages of both MOSFETs and bipolar transistors



Used in wide range of applications as power semiconductor devices

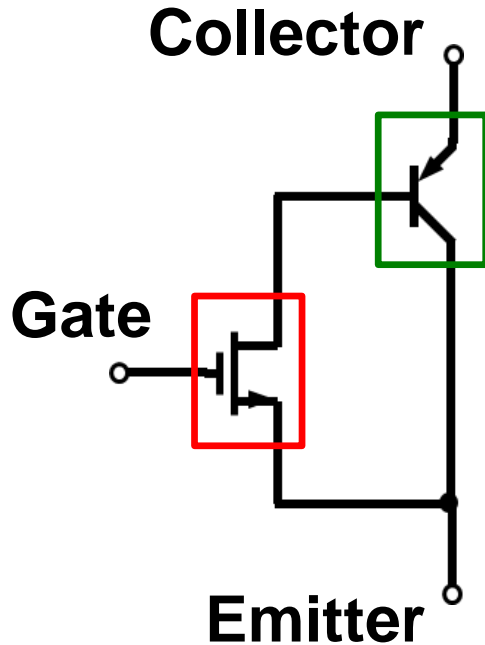


Development of IGBT and its driver circuit is important

IGBT and Driver Circuit

IGBT

(Insulated Gate Bipolar Transistor)



Input part is **MOSFET**
Output part is **bipolar transistor**

Advantages

- Fast operating speed
- Large current amplification factor (~1.2kA)
- High withstand voltage (~3.3kV)

Disadvantage

Large gate capacitance



Driver design is difficult

Objective

IGBT circuit

Parasitic capacitance
and tail current



Switching loss

Parasitic inductance



Excessive overshoot

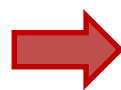
Change drive resistance
during switching



Complex control

Objective

Current
Drive



Reduction of Switching loss
and Excessive overshoot

Simplification of control design

OUTLINE

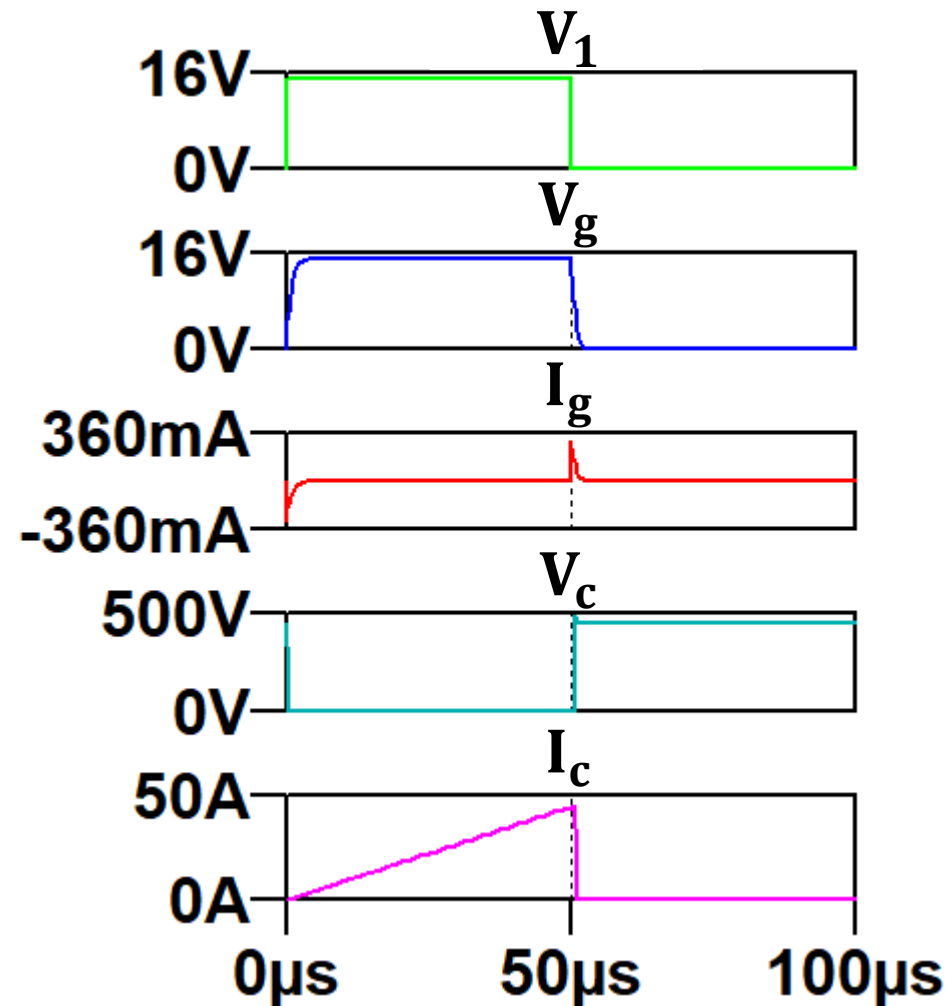
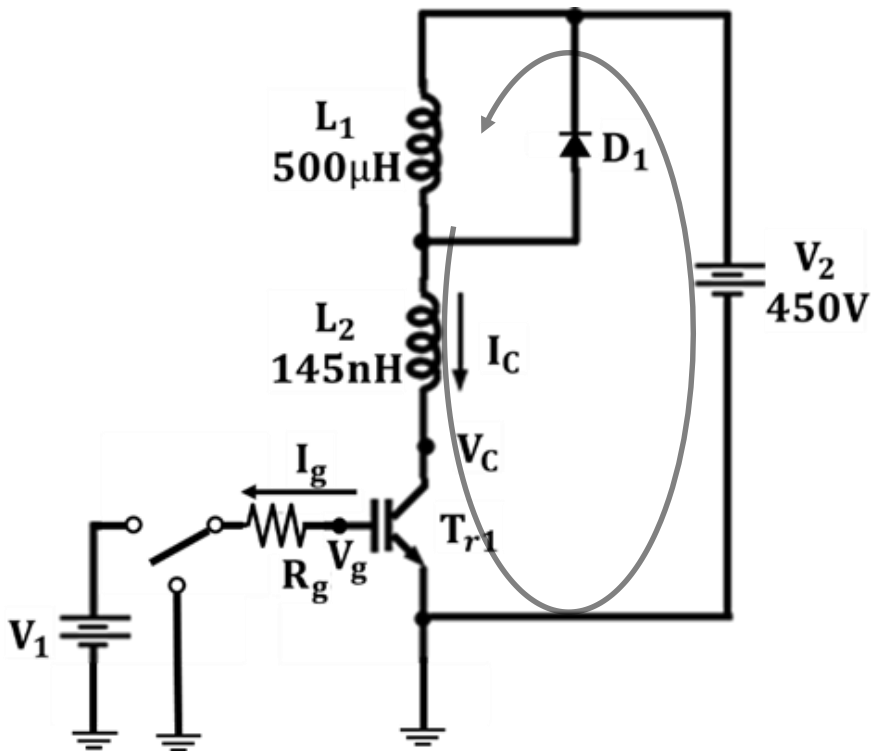
- Research Background and Objective
- **IGBT Evaluation Circuit**
- **IGBT Current Drive Simulation**
 - Current Gate Driver Circuit
 - Simulation Results
- **Gate Current Automatic Control**
 - Analog Value
 - Digital Value
- **Conclusion and Challenges**

Voltage-Driven IGBT Evaluation Circuit (1/2)

Input voltage V_1



V_g turns on IGBT
 I_c gradually flows

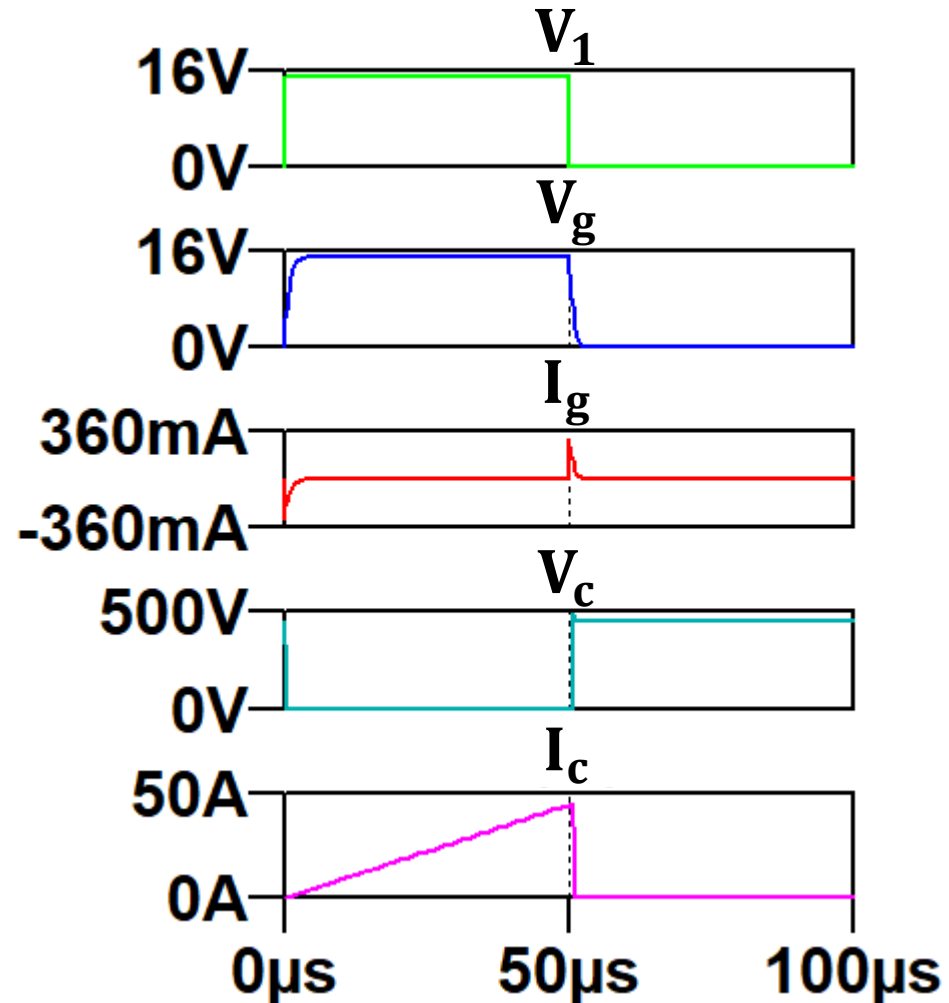
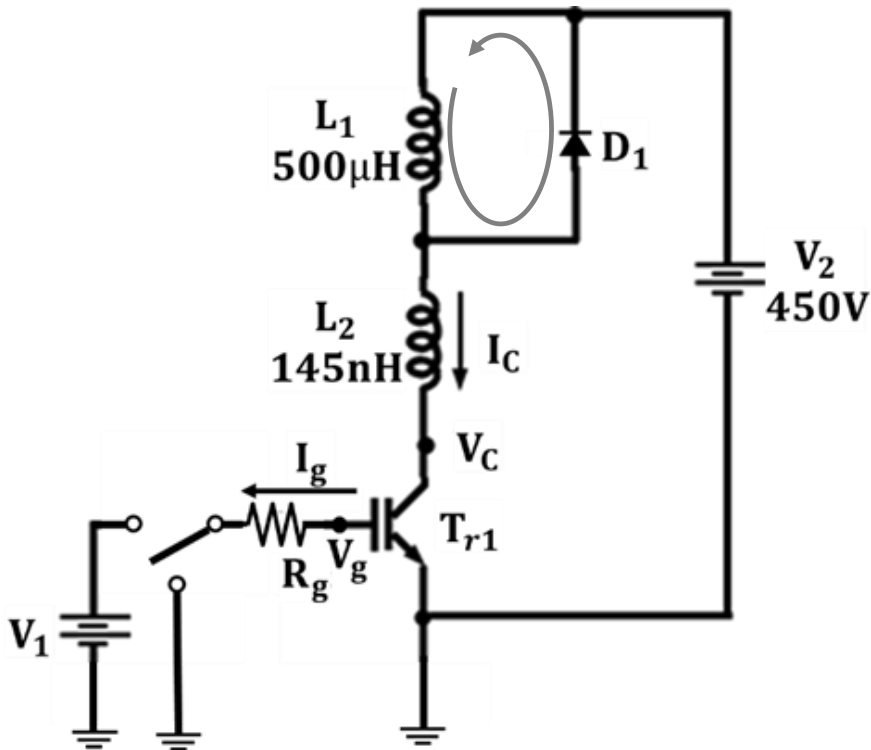


Voltage-Driven IGBT Evaluation Circuit (2/2)

V_1 becomes 0

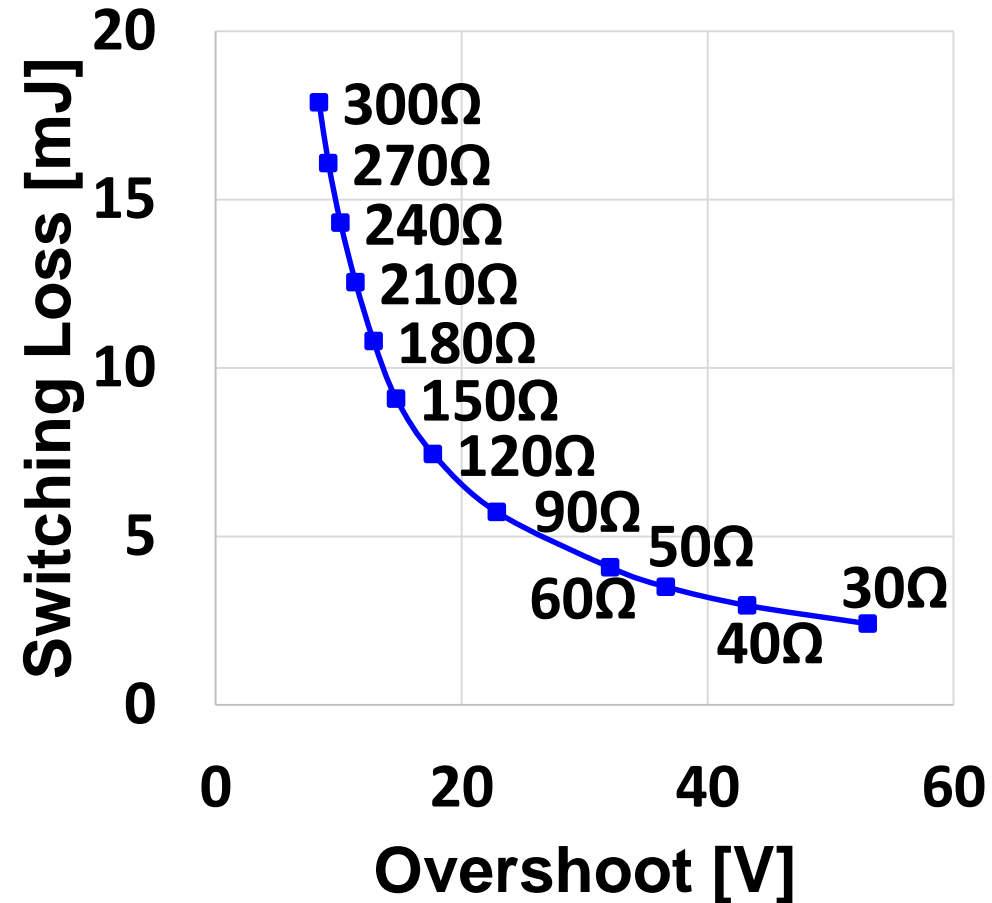
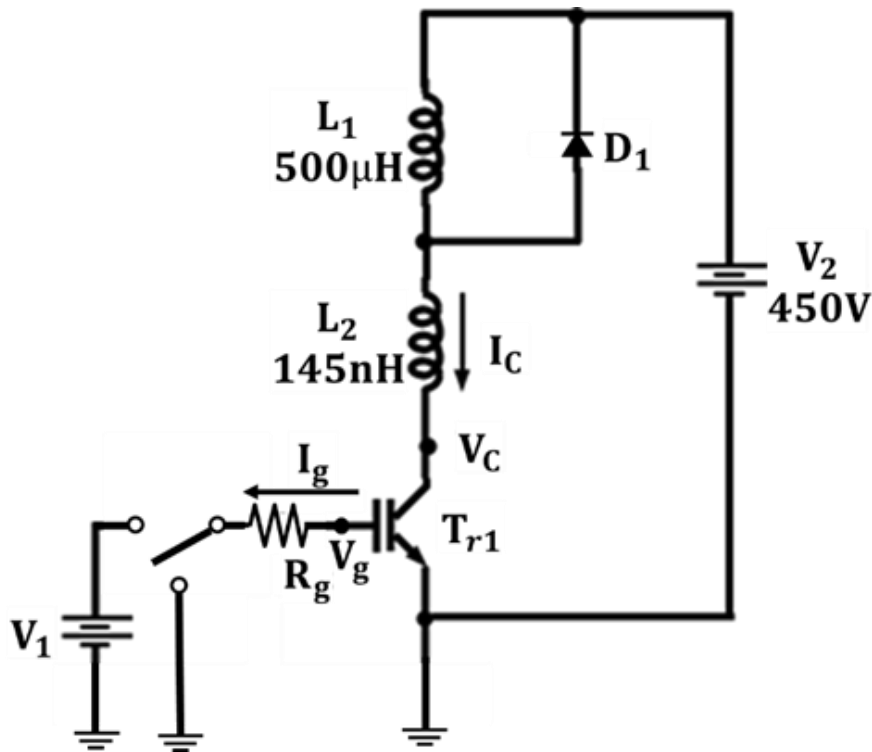


V_g turns off IGBT
 I_c rapidly decreases



Overshoot and Switching Loss during Turn-off

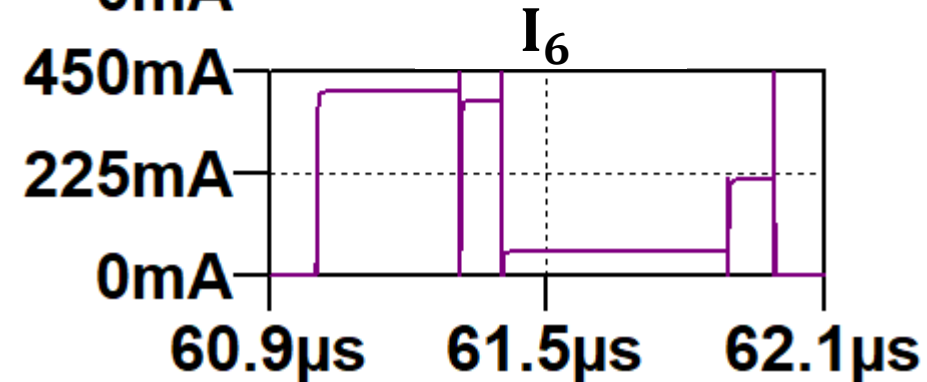
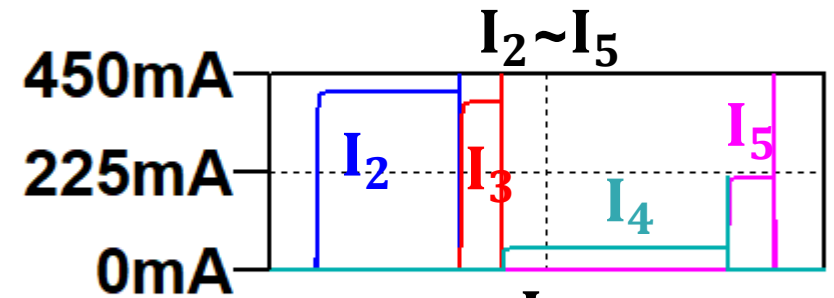
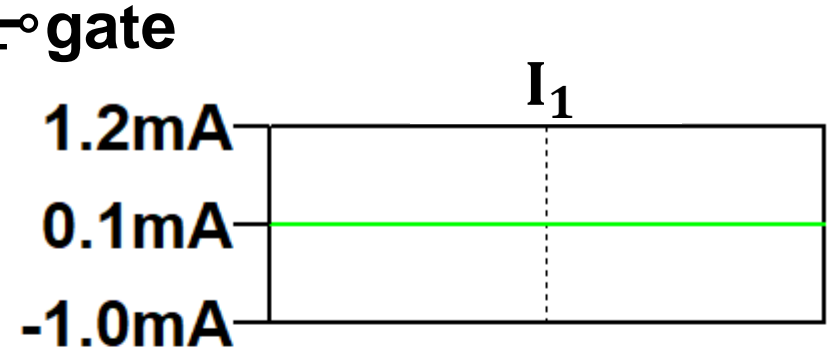
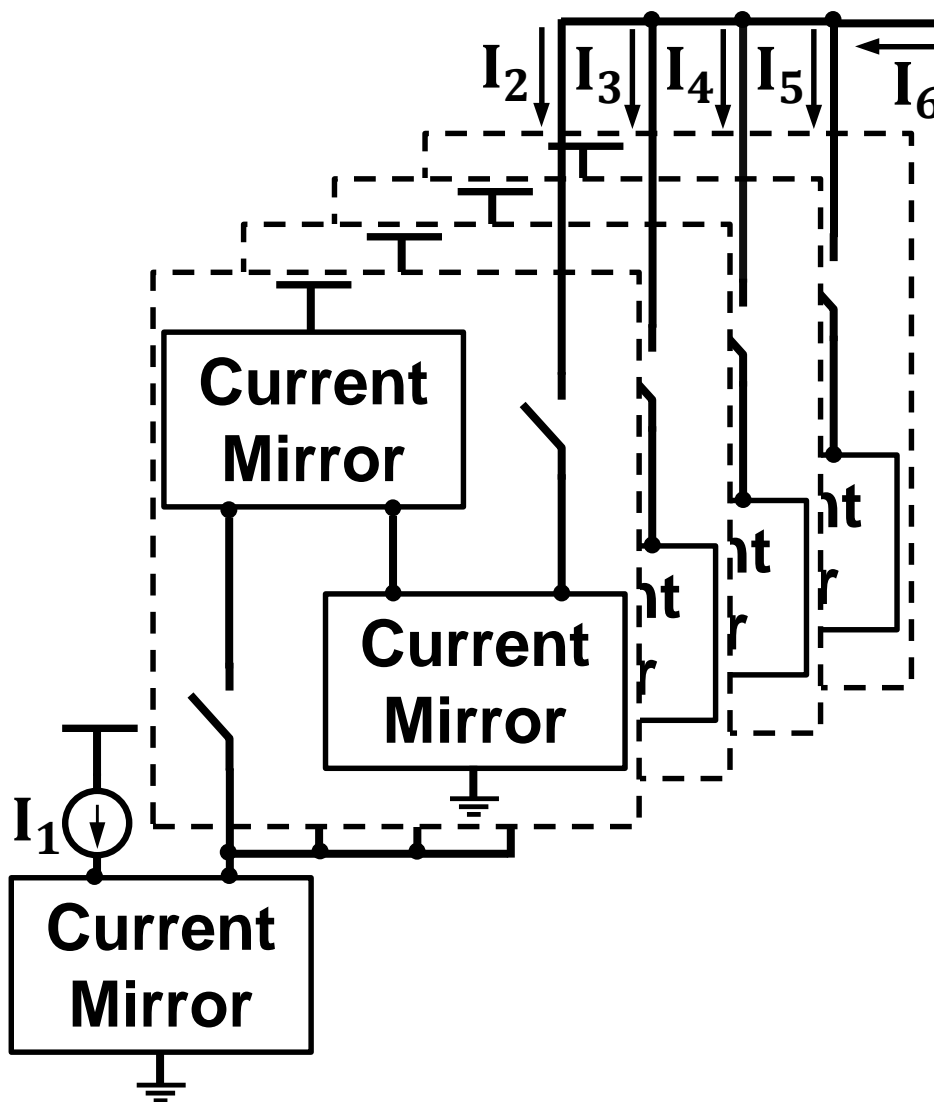
Change gate resistance R_g
from 30Ω to 300Ω



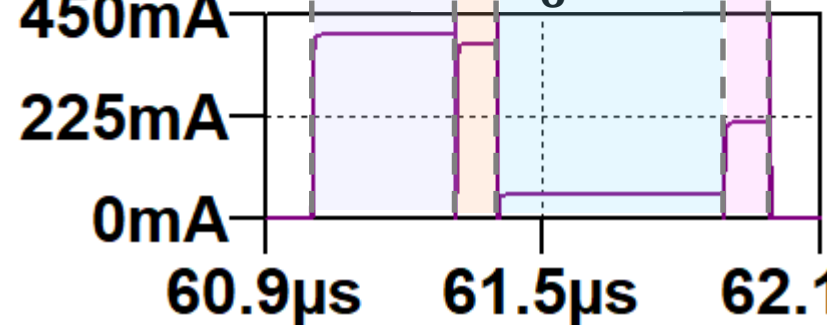
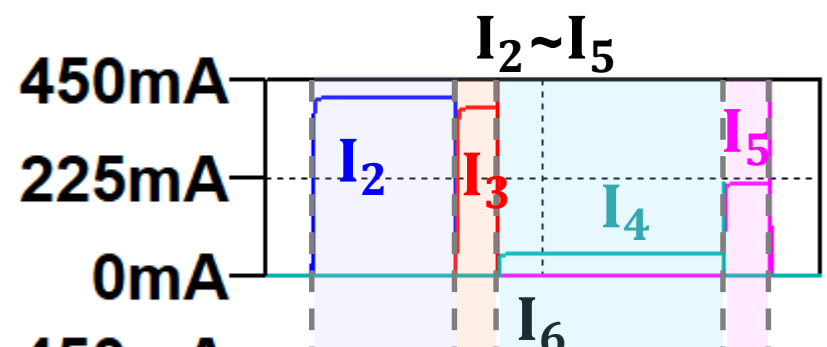
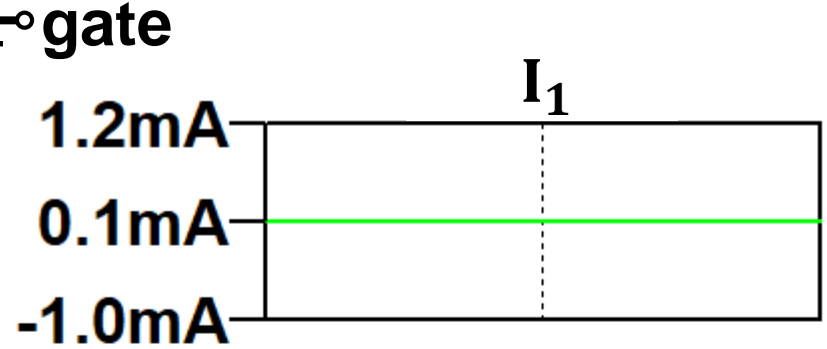
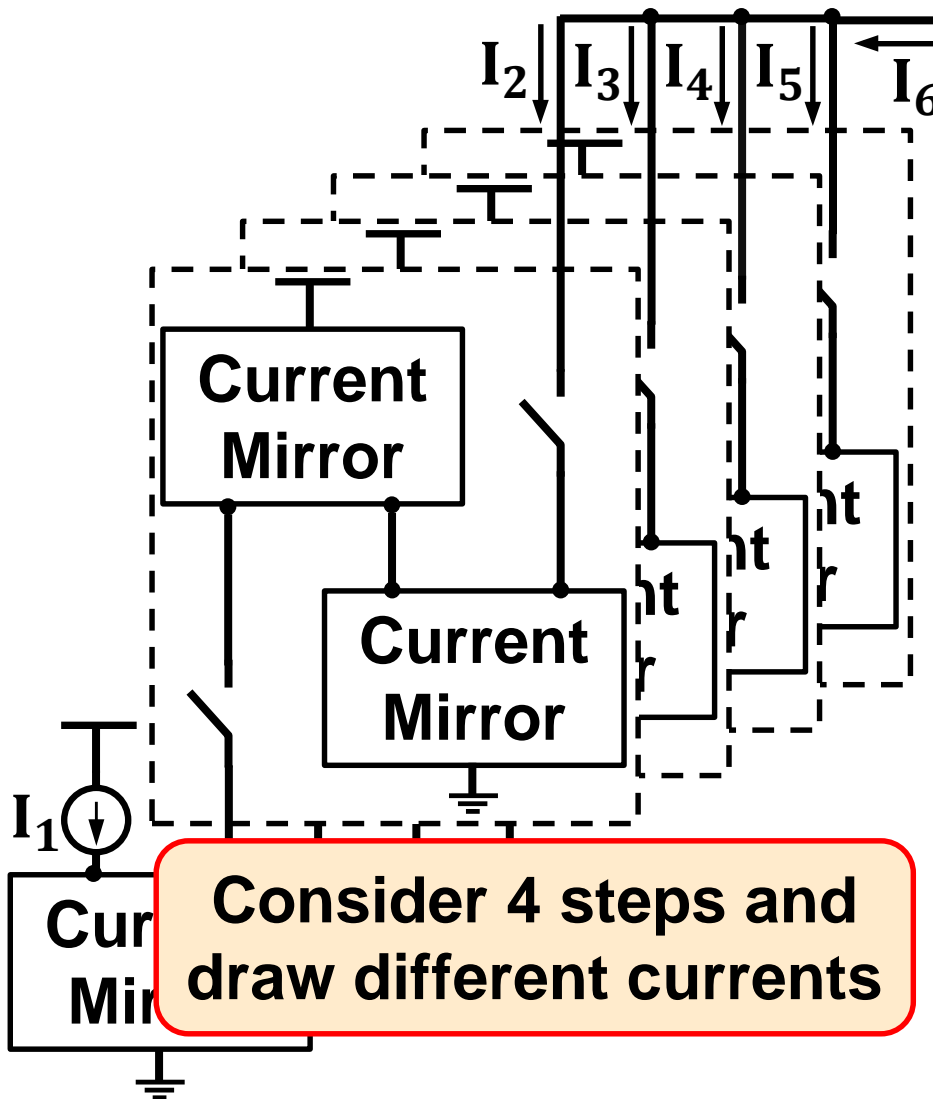
OUTLINE

- Research Background and Objective
- IGBT Evaluation Circuit
- **IGBT Current Drive Simulation**
 - **Current Gate Driver Circuit**
 - Simulation Results
- Gate Current Automatic Control
 - Analog Value
 - Digital Value
- Conclusion and Challenges

Current Gate Driver Circuit (1/2)



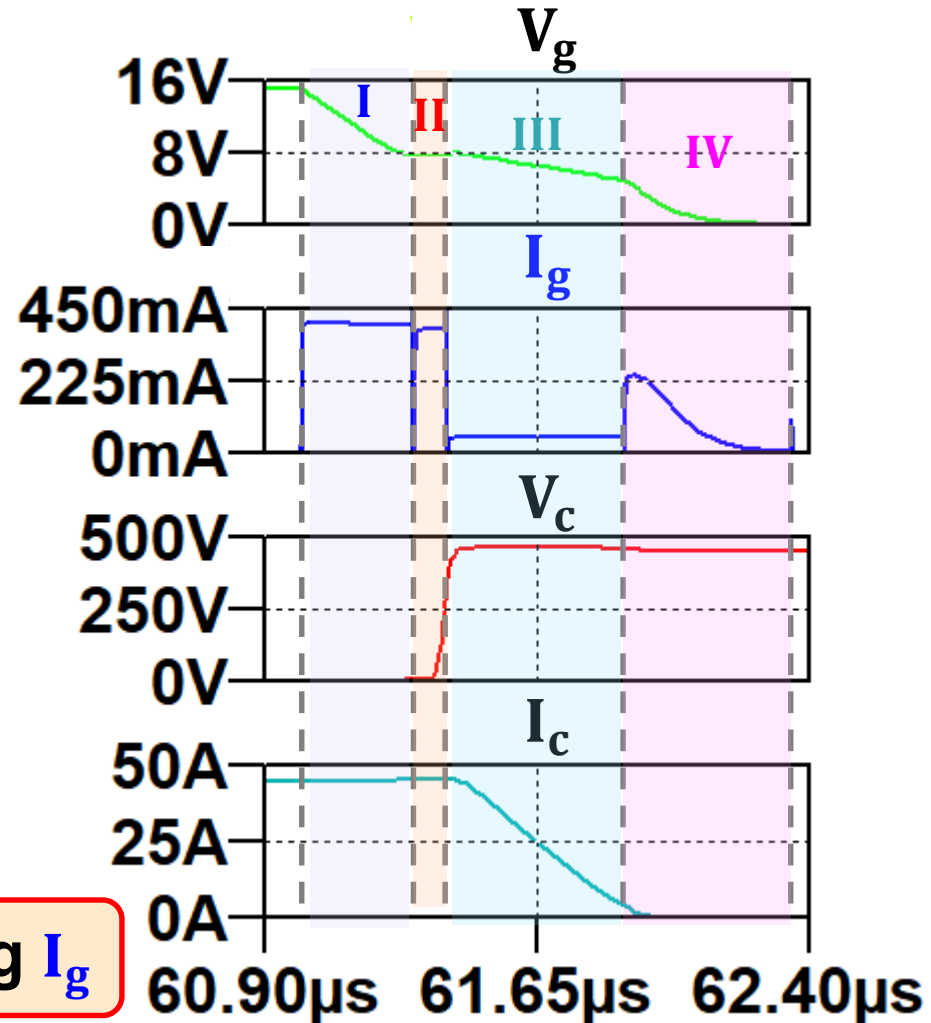
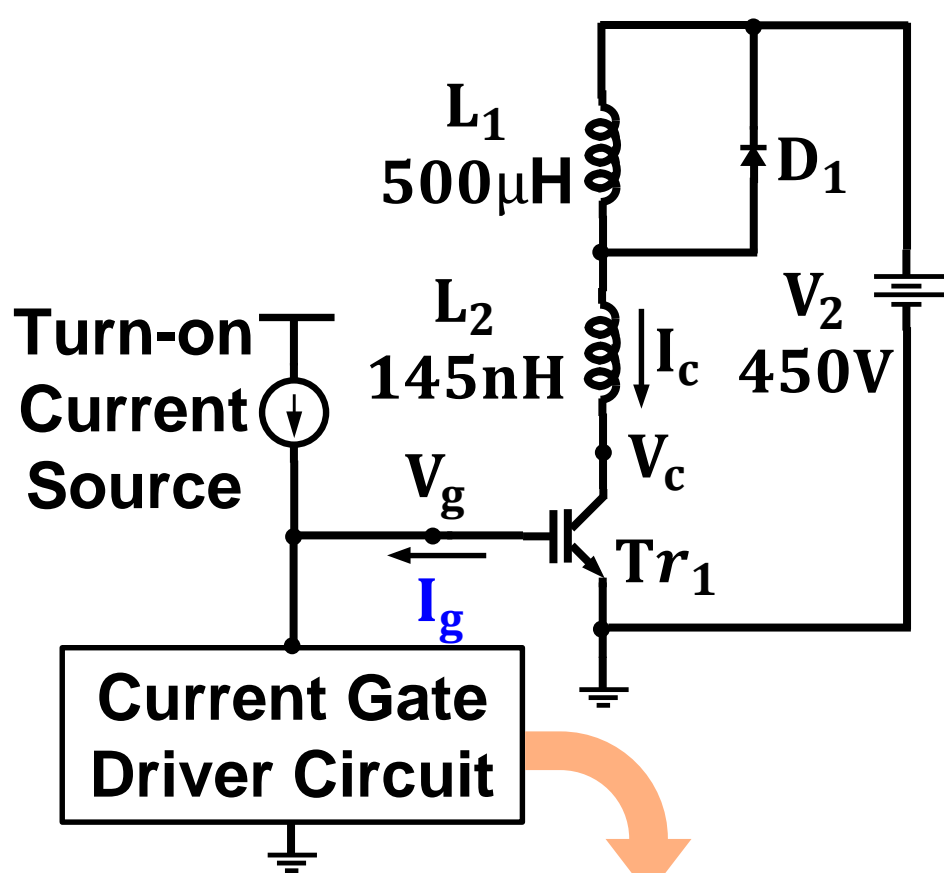
Current Gate Driver Circuit (2/2)



OUTLINE

- Research Background and Objective
- IGBT Evaluation Circuit
- **IGBT Current Drive Simulation**
 - Current Gate Driver Circuit
 - **Simulation Results**
- Gate Current Automatic Control
 - Analog Value
 - Digital Value
- Conclusion and Challenges

IGBT Turn-off Characteristics

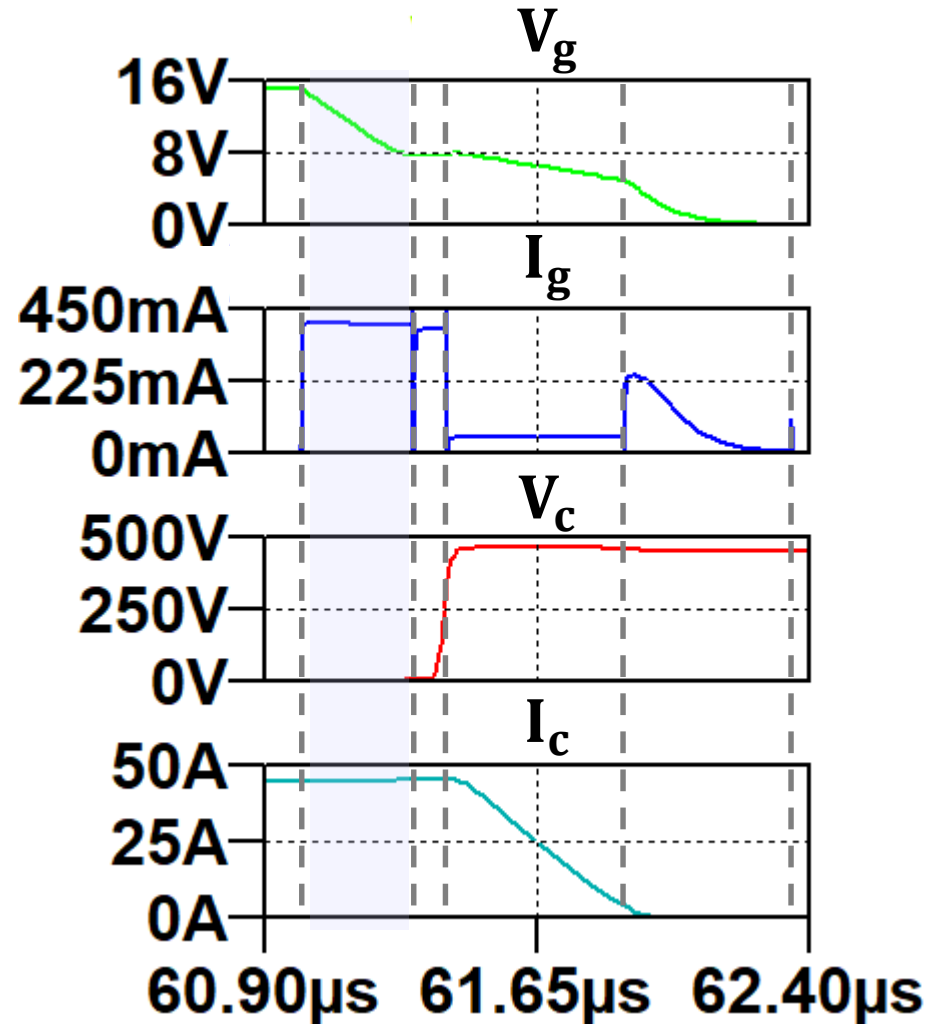


Control of Gate Voltage by Gate Current (Region I)

Region I

V_{g} : Saturation voltage to Miller voltage

No effects on switching loss and overshoot



Control of Gate Voltage by Gate Current (Region II)

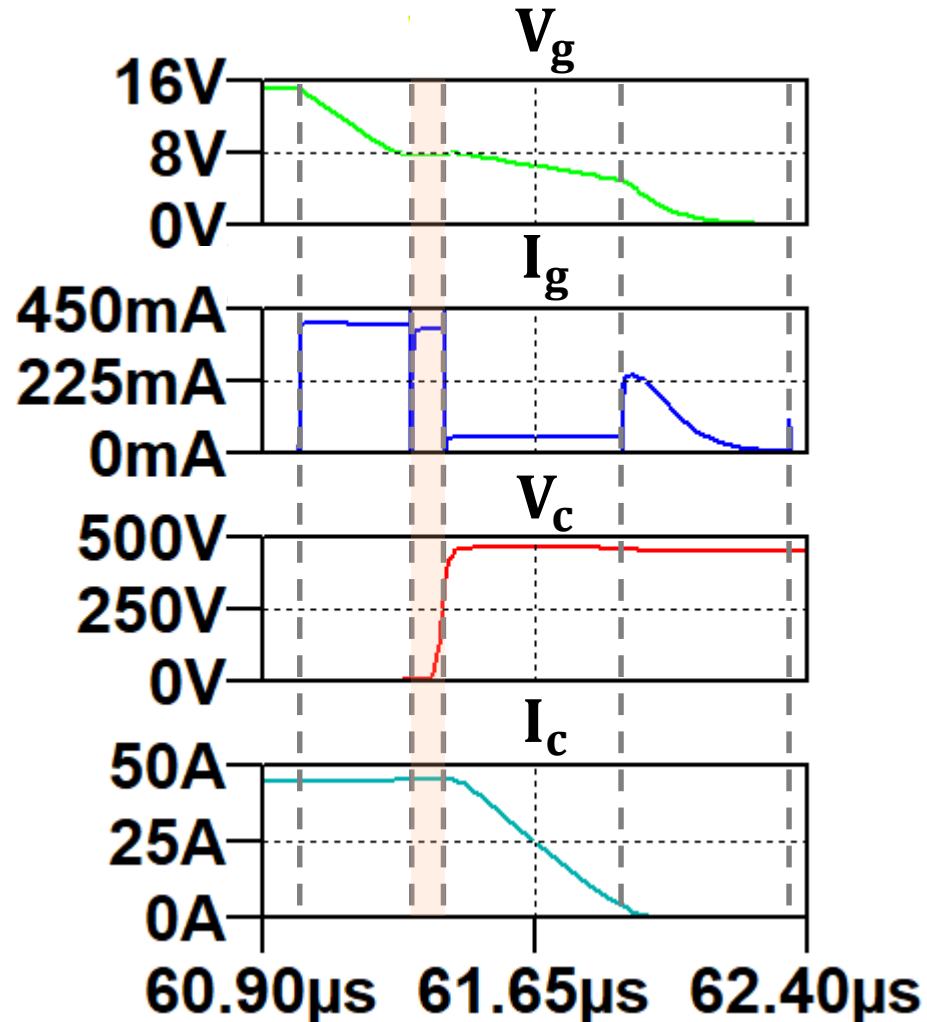
Region II

V_{gg} : Miller period of IGBT

Trade-off between
switching loss and slew rate



Switching loss can be reduced



Control of Gate Voltage by Gate Current (Region III)

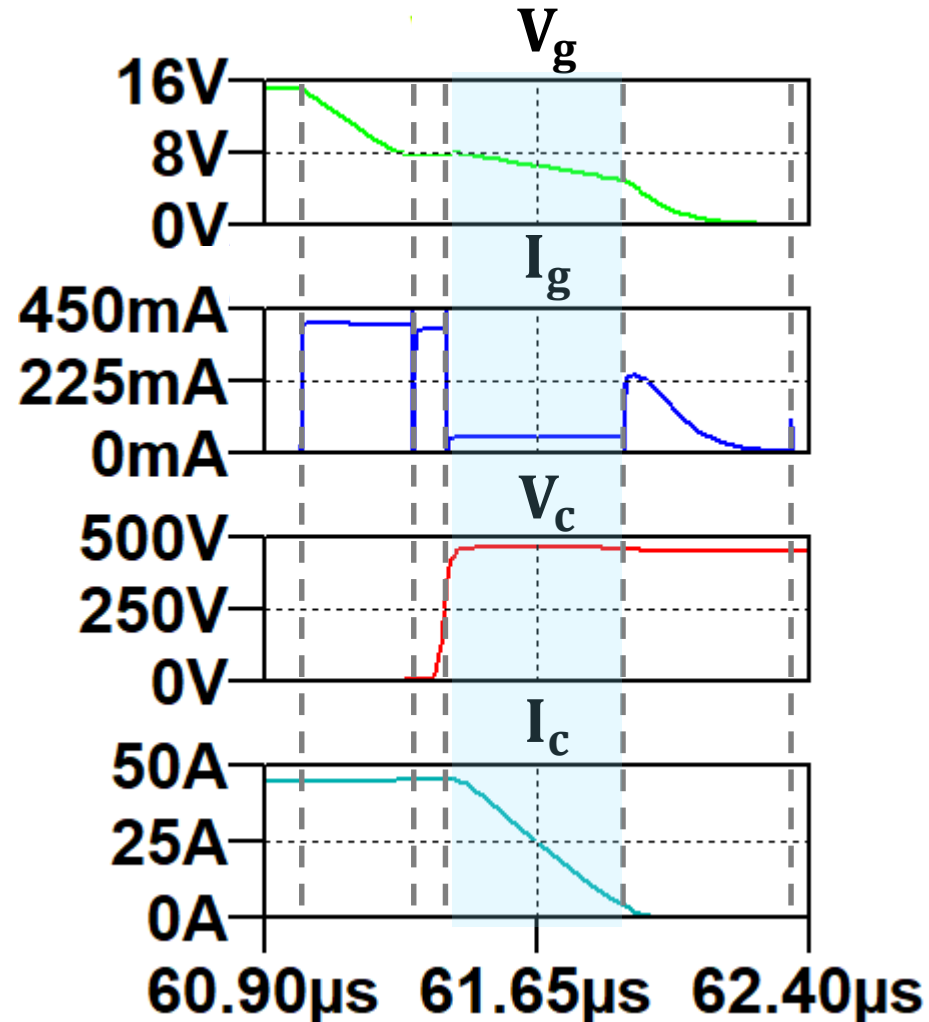
Region III

V_g : Miller voltage
to threshold voltage

Trade-off between
switching loss and overshoot



Overshoot can be reduced



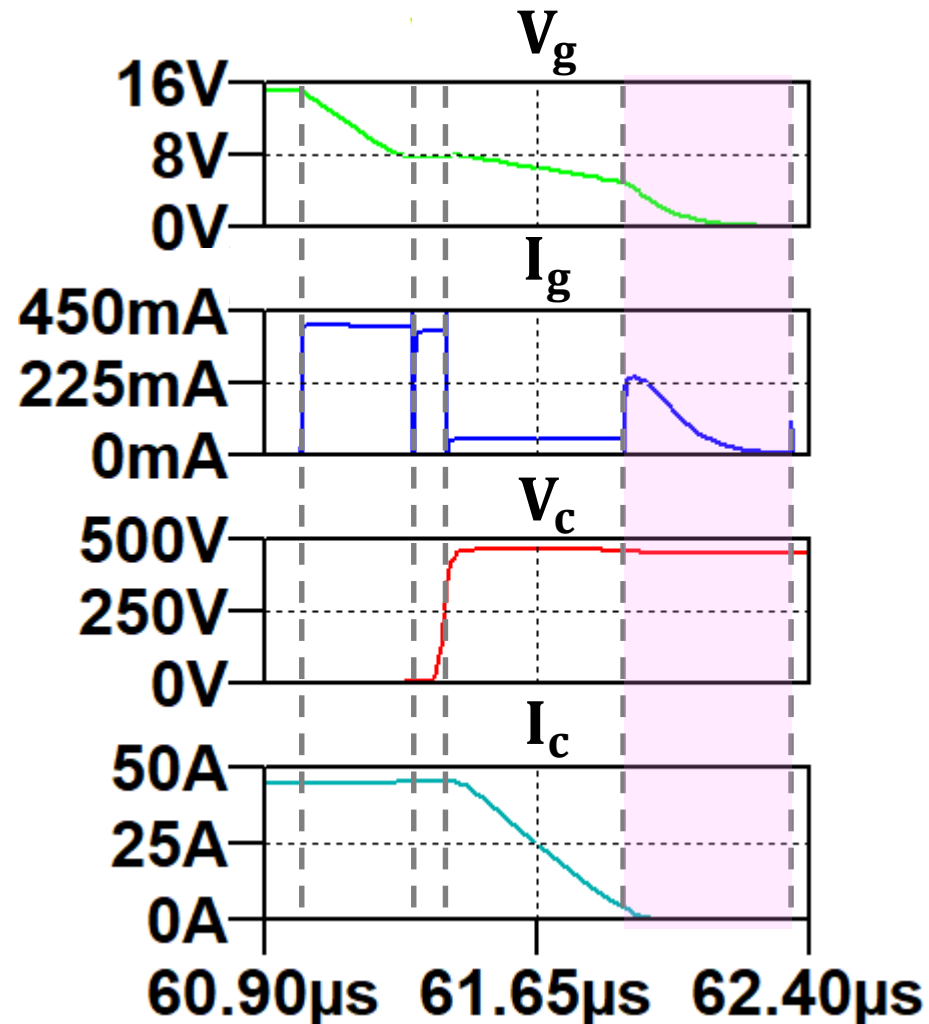
Control of Gate Voltage by Gate Current (Region IV)

Region IV

V_{gg} : Threshold voltage to 0

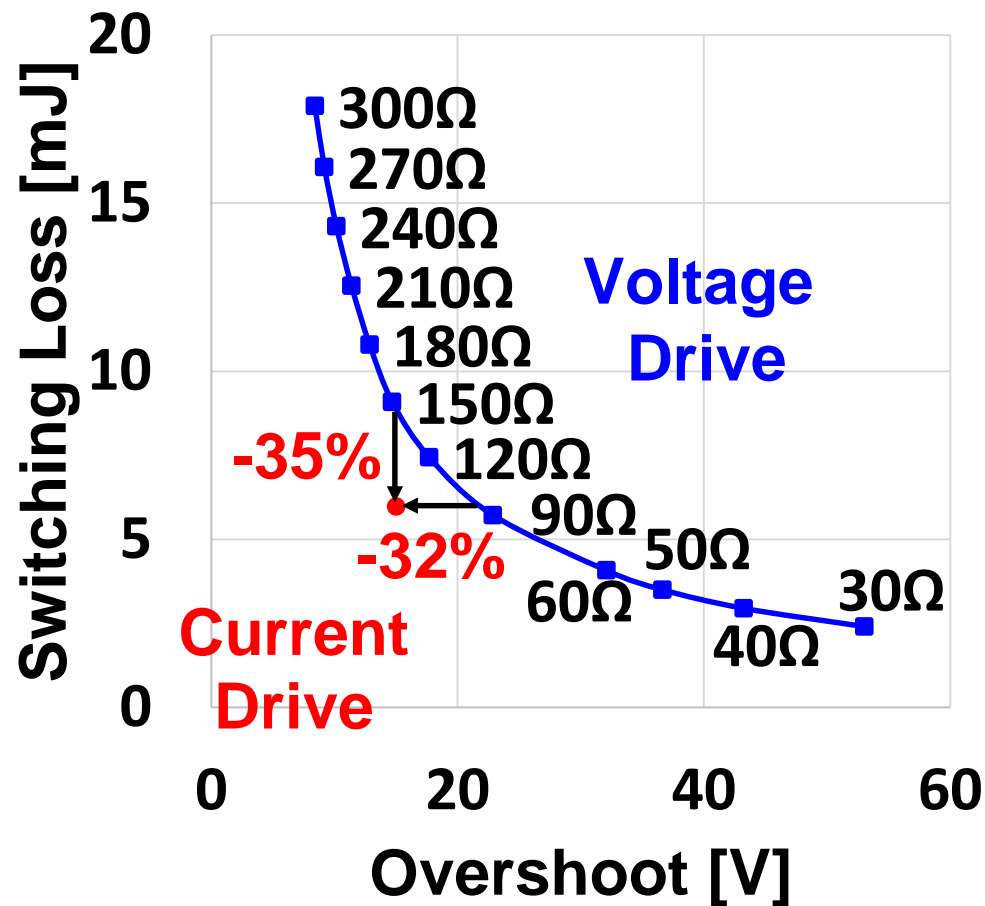
I_{gg} : Uncontrollable due to
I-V characteristics of MOSFETs

No effects on switching loss
and overshoot



Comparison with Voltage Drive

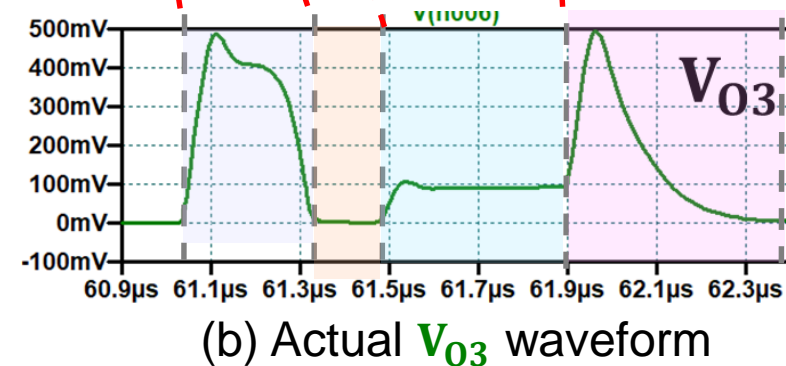
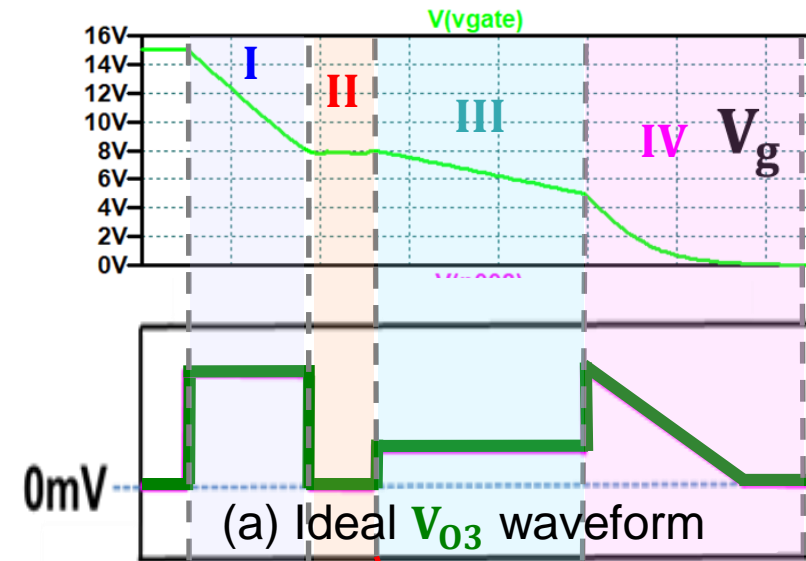
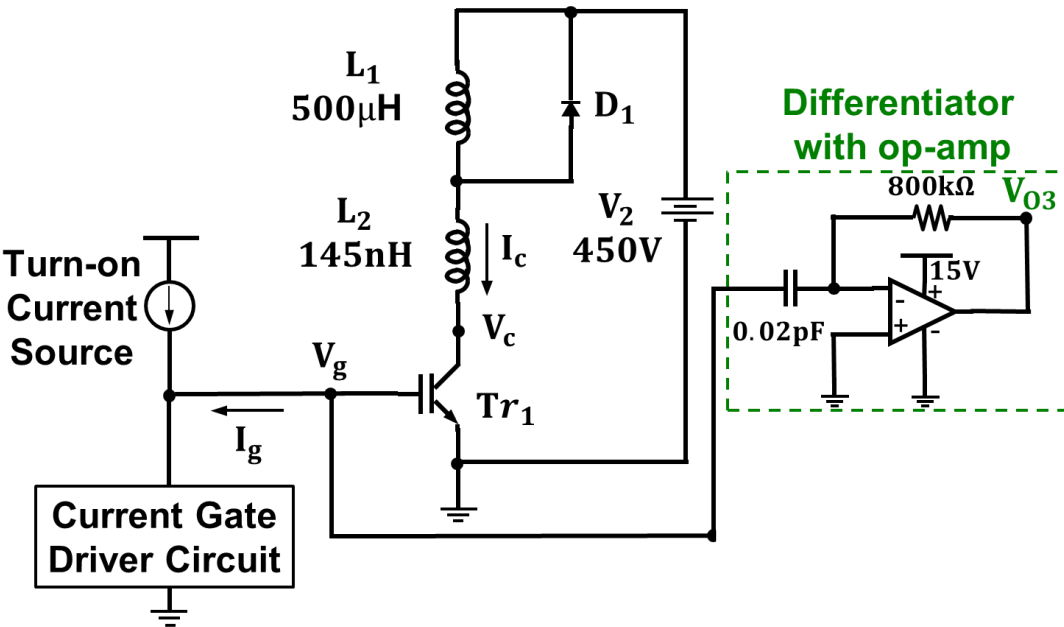
Switching Loss : **-35%**, Overshoot : **-32%**



OUTLINE

- Research Background and Objective
- IGBT Evaluation Circuit
- IGBT Current Drive Simulation
 - Current Gate Driver Circuit
 - Simulation Results
- **Gate Current Automatic Control**
 - **Analog Value**
 - **Digital Value**
- Conclusion and Challenges

Addition of an active differentiator with an operational amplifier



Add **operational amplifier differentiator**
Model: UniversalOpamp2 (LTspice)

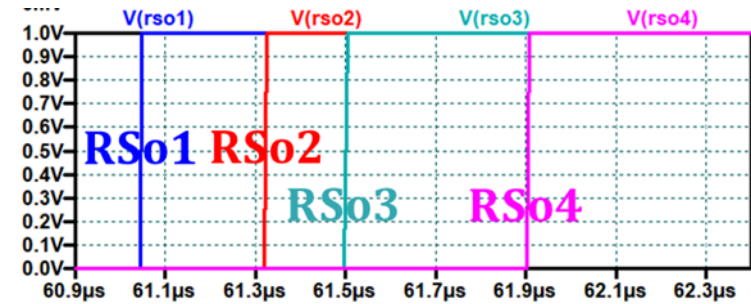
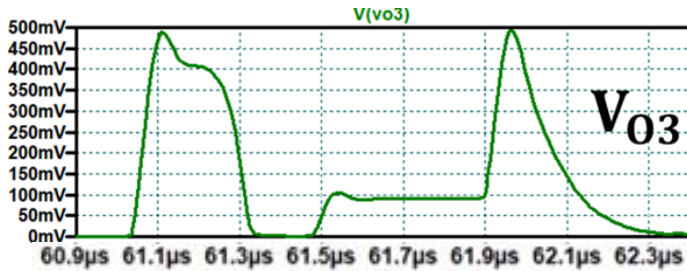


Observe the change in the slope of V_g

OUTLINE

- Research Background and Objective
- IGBT Evaluation Circuit
- IGBT Current Drive Simulation
 - Current Gate Driver Circuit
 - Simulation Results
- **Gate Current Automatic Control**
 - Analog Value
 - **Digital Value**
- Conclusion and Challenges

Automatic Discrimination of Operation Regions (Digital value)



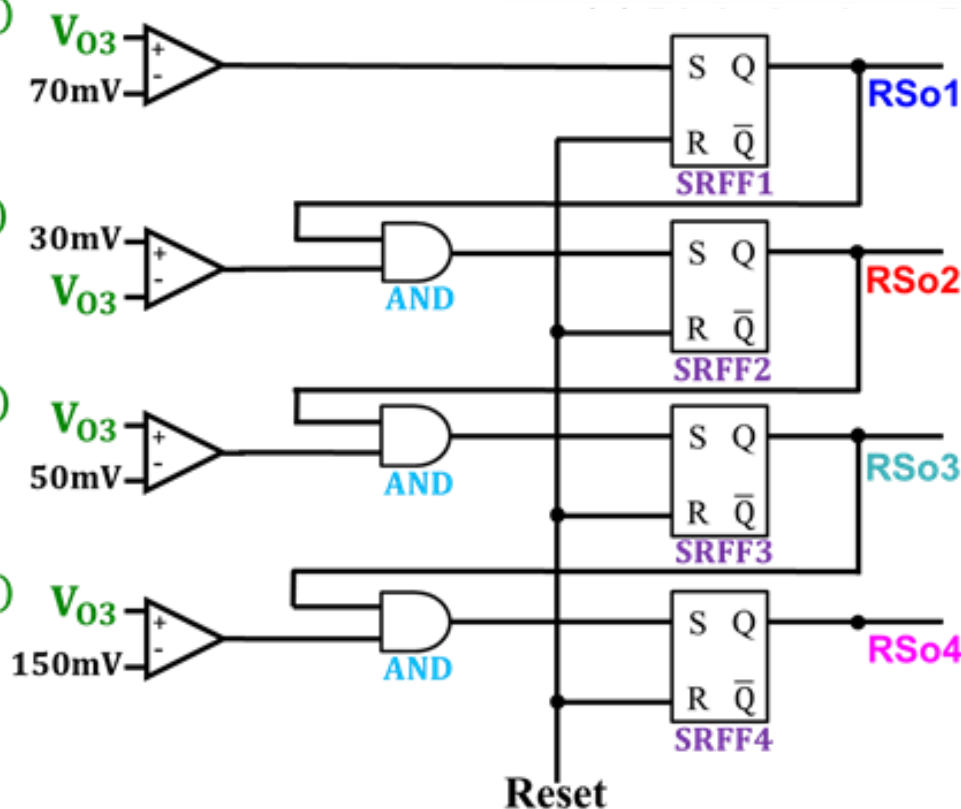
Analog Value

Comparator1(Cp1)
If $V_{03} > 70\text{mV}$
Output Cp1 = 1

Comparator2(Cp2)
If $30\text{mV} > V_{03}$
Output Cp2 = 1

Comparator3(Cp3)
If $V_{03} > 50\text{mV}$
Output Cp3 = 1

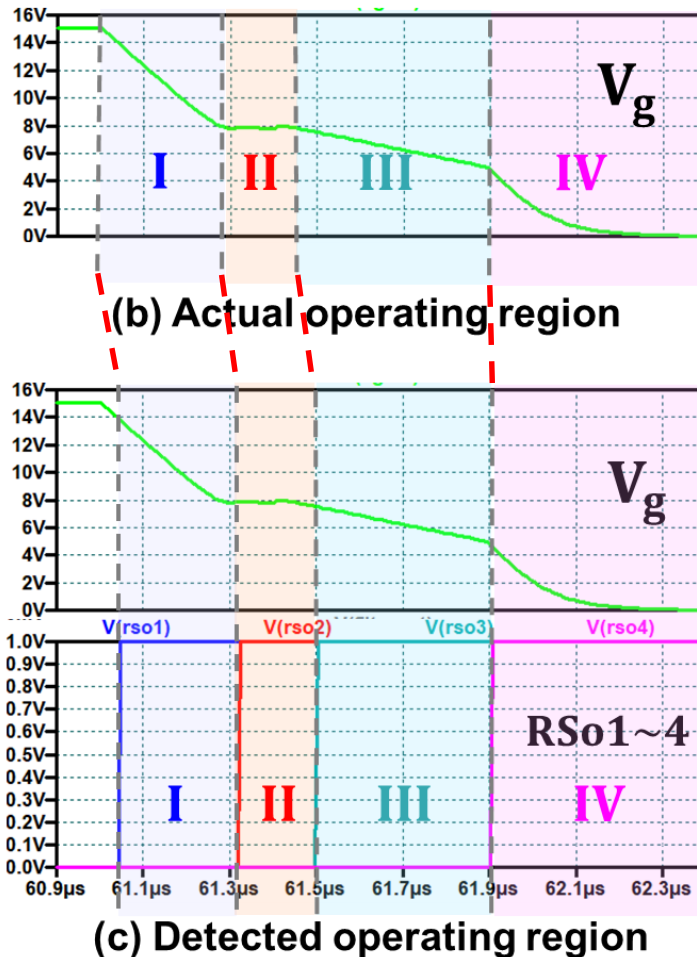
Comparator4(Cp4)
If $V_{03} > 150\text{mV}$
Output Cp4 = 1



Digital value

The detected values (V_{03}) are used to discriminate the operating region using a comparator and SRFF.

Digital Value \Rightarrow Operation Regions

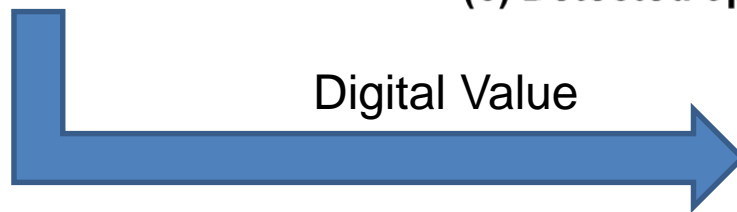


Delay in response speed of V_{03} to variation in V_g



Detection timing of operating region transitions delayed than actual operating region

Operation Regions



	RSo1	RSo2	RSo3	RSo4
Reg I	1	0	0	0
Reg II	1	1	0	0
Reg III	1	1	1	0
Reg IV	1	1	1	1

OUTLINE

- **Research Background and Objective**
- **IGBT Evaluation Circuit**
- **IGBT Current Drive Simulation**
 - **Current Gate Driver Circuit**
 - **Simulation Results**
- **Gate Current Automatic Control**
 - **Analog Value**
 - **Digital Value**
- **Conclusion and Challenges**

Conclusion and Challenges

Conclusion

- Proposal of current drive circuit to control gate voltage of IGBT
- During turn-off, when compared to conventional voltage drive :
Current Drive → switching loss **(-35%)**, overshoot **(-32%)**
- Automatic discrimination of the operating region of current-driven IGBT gate driver circuits.

Challenges

- To verify the effect of detection delay in the operating region change on switching loss and overshoot.



Kobayashi
Laboratory

Thank you very much